Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/682,135	BECKER ET AL.
Examiner	**Art Unit**
Sun J. Lin	2825

SEARCHED			
Class	Subclass	Date	Examiner
716	10	8/1/2005	JSL
716	1	8/1/2005	JSL
716	8	8/1/2005	JSL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
716	**10**	**8/2/2005**	**JSL**
716	1	8/2/2005	JSL
716	8	8/2/2005	JSL

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST [USPAT;US-PGPUB;UPO;JPO;DERWENT;IBM_TDB]	8/1/2005	JSL
EAST [USPAT;US-PGPUB;UPO;JPO;DERWENT;IBM_TDB]	8/2/2005	JSL
EAST [USPAT;US-PGPUB;UPO;JPO;DERWENT;IBM_TDB]	8/18/2005	JSL
IEEE	8/2/2005	JSL
IEEE	8/18/2005	JSL